

<b>Notice of References Cited</b>	Application/Control No. 10/813,327		Applicant(s)/Patent Under Reexamination SUH ET AL.	
	Examiner ANDREW WENDELL		Art Unit 2618	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0209643	10-2004	Welsh, Linda Bucsay	455/556.1
*	B	US-2001/0034246	10-2001	Hutchison et al.	455/557
*	C	US-6,968,218	11-2005	Petty, John S.	455/572
*	D	US-6,915,142	07-2005	Wietfeldt, Richard D.	455/557
*	E	US-5,777,991	07-1998	Adachi et al.	370/352
*	F	US-2005/0066067	03-2005	Suh, Woon-Sik	710/001
*	G	US-6,874,054	03-2005	Clayton et al.	710/310
*	H	US-6,738,845	05-2004	Hadwiger et al.	710/240
*	I	US-7,062,588	06-2006	Usui et al.	710/306
*	J	US-2004/0225760	11-2004	Lee, Seung-Bum	710/022
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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